

Notice of References Cited

Application/Control No.

10/689,108

Applicant(s)/Patent Under

Reexamination

BLANKENSHIP ET AL.

Examiner

Alexandra K Pechhold

Art Unit

3671

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,306,750 A	04-1994	Goodrich et al.	524/59
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	NY State DOT: Index of all Region 4 Special Specifications- lists Word Perfect File 04403.017901M entitled "Reflective Crack Relief HMA Interlayer", last page update June 3, 2003
	V	Item 04402.017901M "Reflective Crack Relief HMA Interlayer", Dated 8/7/02
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.